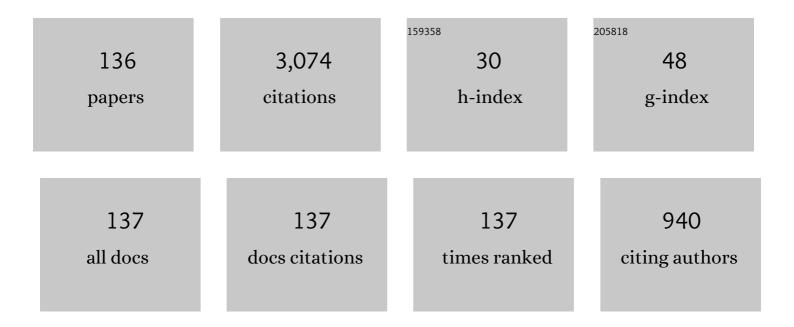
Chien-Wei Wu

List of Publications by Year in descending order

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CHIEN-M/FLM/LL

| # | Article | IF | CITATIONS |
|----|---|-----|-----------|
| 1 | An overview of theory and practice on process capability indices for quality assurance. International Journal of Production Economics, 2009, 117, 338-359. | 5.1 | 256 |
| 2 | An effective decision making method for product acceptance. Omega, 2007, 35, 12-21. | 3.6 | 113 |
| 3 | A variables sampling plan based on Cpmk for product acceptance determination. European Journal of Operational Research, 2008, 184, 549-560. | 3.5 | 103 |
| 4 | Variables sampling inspection scheme for resubmitted lots based on the process capability index Cpk. European Journal of Operational Research, 2012, 217, 560-566. | 3.5 | 102 |
| 5 | Variable sampling inspection for resubmitted lots based on process capability index Cpk for normally distributed items. Applied Mathematical Modelling, 2013, 37, 667-675. | 2.2 | 99 |
| 6 | Critical acceptance values and sample sizes of a variables sampling plan for very low fraction of defectives. Omega, 2006, 34, 90-101. | 3.6 | 90 |
| 7 | Monitoring Multivariate Process Variability for Individual Observations. Journal of Quality Technology, 2007, 39, 258-278. | 1.8 | 85 |
| 8 | A resubmitted sampling scheme by variables inspection for controlling lot fraction nonconforming. International Journal of Production Research, 2014, 52, 3744-3754. | 4.9 | 68 |
| 9 | An efficient approach to determine cell formation, cell layout and intracellular machine sequence in cellular manufacturing systems. Computers and Industrial Engineering, 2013, 66, 438-450. | 3.4 | 67 |
| 10 | Variables sampling plans with PPM fraction of defectives and process loss consideration. Journal of the Operational Research Society, 2006, 57, 450-459. | 2.1 | 66 |
| 11 | Developing a variables repetitive group sampling plan based on process capability index <i>C</i> _{<i>pk</i>} with unknown mean and variance. Journal of Statistical Computation and Simulation, 2013, 83, 1507-1517. | 0.7 | 63 |
| 12 | A multivariate EWMA control chart for monitoring process variability with individual observations. IIE Transactions, 2005, 37, 1023-1035. | 2.1 | 62 |
| 13 | An efficient inspection scheme for variables based on Taguchi capability index. European Journal of Operational Research, 2012, 223, 116-122. | 3.5 | 60 |
| 14 | Decision-making in testing process performance with fuzzy data. European Journal of Operational Research, 2009, 193, 499-509. | 3.5 | 54 |
| 15 | Developing a sampling plan by variables inspection for controlling lot fraction of defectives. Applied Mathematical Modelling, 2014, 38, 2303-2310. | 2.2 | 49 |
| 16 | Capability-based quick switching sampling system for lot disposition. Applied Mathematical Modelling, 2017, 52, 131-144. | 2.2 | 45 |
| 17 | Procedure for supplier selection based on Cpm applied to super twisted nematic liquid crystal display processes. International Journal of Production Research, 2004, 42, 2719-2734. | 4.9 | 43 |
| 18 | Developing a variables multiple dependent state sampling plan with simultaneous consideration of process yield and quality loss. International Journal of Production Research, 2017, 55, 2351-2364. | 4.9 | 43 |

| # | Article | IF | CITATIONS |
|----|--|-----|-----------|
| 19 | Balanced carrier transport in organic solar cells employing embedded indium-tin-oxide nanoelectrodes. Applied Physics Letters, 2011, 98, . | 1.5 | 41 |
| 20 | Design and Construction of a Variables Repetitive Group Sampling Plan for Unilateral Specification Limit. Communications in Statistics Part B: Simulation and Computation, 2014, 43, 1866-1878. | 0.6 | 40 |
| 21 | Assessing process capability based on Bayesian approach with subsamples. European Journal of Operational Research, 2008, 184, 207-228. | 3.5 | 38 |
| 22 | Mixed Acceptance Sampling Plans for Product Inspection Using Process Capability Index. Quality Engineering, 2014, 26, 450-459. | 0.7 | 38 |
| 23 | A flexible process-capability-qualified resubmission-allowed acceptance sampling scheme. Computers and Industrial Engineering, 2015, 80, 62-71. | 3.4 | 38 |
| 24 | A modified variables repetitive group sampling plan with the consideration of preceding lots information. Annals of Operations Research, 2016, 238, 355-373. | 2.6 | 37 |
| 25 | A quick switching sampling system by variables for controlling lot fraction nonconforming. International Journal of Production Research, 2016, 54, 1839-1849. | 4.9 | 34 |
| 26 | Variable-sampling plans based on lifetime-performance index under exponential distribution with censoring and its extensions. Applied Mathematical Modelling, 2018, 55, 81-93. | 2.2 | 34 |
| 27 | The construction of a modified sampling scheme by variables inspection based on the one-sided capability index. Computers and Industrial Engineering, 2018, 122, 87-94. | 3.4 | 34 |
| 28 | Capability Testing Based onCpm with Multiple Samples. Quality and Reliability Engineering International, 2005, 21, 29-42. | 1.4 | 33 |
| 29 | Assessing process capability based on the lower confidence bound of Cpk for asymmetric tolerances. European Journal of Operational Research, 2008, 190, 205-227. | 3.5 | 33 |
| 30 | Advanced dispatching rules for large-scale manufacturing systems. International Journal of Advanced Manufacturing Technology, 2013, 67, 1-3. | 1.5 | 33 |
| 31 | A Sampling Scheme for Resubmitted Lots Based on One-Sided Capability Indices. Quality Technology and Quantitative Management, 2015, 12, 501-515. | 1.1 | 32 |
| 32 | Developing a variables repetitive group sampling scheme by considering process yield and quality loss. International Journal of Production Research, 2015, 53, 2239-2251. | 4.9 | 32 |
| 33 | A Novel Lot Sentencing Method by Variables Inspection Considering Multiple Dependent State. Quality and Reliability Engineering International, 2016, 32, 985-994. | 1.4 | 32 |
| 34 | Production quality and yield assurance for processes with multiple independent characteristics. European Journal of Operational Research, 2006, 173, 637-647. | 3.5 | 31 |
| 35 | Design and construction of a variables multiple dependent state sampling plan based on process yield. European Journal of Industrial Engineering, 2015, 9, 819. | 0.5 | 31 |
| 36 | Designing a variables two-plan sampling system of type TNTVSS-(<i>n</i> _T , <i>n</i> _N ; <i>k</i>) for controlling process fraction nonconforming with unilateral specification limit. International Journal of Production Research, 2015, 53, 2011-2025. | 4.9 | 30 |

| # | Article | IF | CITATIONS |
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| 37 | Bootstrap approach for supplier selection based on production yield. International Journal of Production Research, 2008, 46, 5211-5230. | 4.9 | 29 |
| 38 | Efficient methods for comparing two process yields – strategies on supplier selection. International Journal of Production Research, 2013, 51, 1587-1602. | 4.9 | 29 |
| 39 | Measuring manufacturing capability for couplers and wavelength division multiplexers. International Journal of Advanced Manufacturing Technology, 2005, 25, 533-541. | 1.5 | 27 |
| 40 | A Bayesian approach for assessing process precision based on multiple samples. European Journal of Operational Research, 2005, 165, 685-695. | 3.5 | 26 |
| 41 | A repetitive group sampling plan by variables inspection for product acceptance determination. European Journal of Industrial Engineering, 2015, 9, 308. | 0.5 | 26 |
| 42 | Process capability assessment for index Cpkbased on bayesian approach. Metrika, 2005, 61, 221-234. | 0.5 | 25 |
| 43 | A variables multiple dependent state sampling plan based on a one-sided capability index. Quality Engineering, 2017, 29, 719-729. | 0.7 | 25 |
| 44 | A new lot sentencing approach by variables inspection based on process yield. International Journal of Production Research, 2018, 56, 4087-4099. | 4.9 | 24 |
| 45 | An alternative approach to test process capability for unilateral specification with subsamples. International Journal of Production Research, 2007, 45, 5397-5415. | 4.9 | 21 |
| 46 | An efficient method for dynamic-demand joint replenishment problem with multiple suppliers and multiple vehicles. International Journal of Production Research, 2017, 55, 1065-1084. | 4.9 | 21 |
| 47 | A variable-type skip-lot sampling plan for products with a unilateral specification limit. International Journal of Production Research, 2021, 59, 4140-4156. | 4.9 | 21 |
| 48 | A variables-type multiple-dependent-state sampling plan based on the lifetime performance index under a Weibull distribution. Annals of Operations Research, 2022, 311, 381-399. | 2.6 | 20 |
| 49 | Using a novel approach to assess process performance in the presence of measurement errors. Journal of Statistical Computation and Simulation, 2011, 81, 301-314. | 0.7 | 19 |
| 50 | Design and construction of a variables switch-based sampling system for product acceptance determination. International Journal of Advanced Manufacturing Technology, 2019, 101, 2643-2652. | 1.5 | 19 |
| 51 | Estimating and testing process yield with imprecise data. Expert Systems With Applications, 2009, 36, 11006-11012. | 4.4 | 18 |
| 52 | Lifetime performance-qualified sampling system under a Weibull distribution with failure-censoring. Quality Engineering, 2021, 33, 404-416. | 0.7 | 18 |
| 53 | A lots-dependent variables sampling plan considering supplier's process loss and buyer's stipulated specifications requirement. International Journal of Production Research, 2015, 53, 6308-6319. | 4.9 | 17 |
| 54 | Processâ€capabilityâ€qualified adjustable multipleâ€dependentâ€state sampling plan for a longâ€term supplier–buyer relationship. Quality and Reliability Engineering International, 2021, 37, 583-597. | 1.4 | 17 |

| # | Article | IF | CITATIONS |
|----|---|-------------------------------|-------------------|
| 55 | Generalized Inference for Measuring Process Yield With the Contamination of Measurement Errors—Quality Control for Silicon Wafer Manufacturing Processes in the Semiconductor Industry. IEEE Transactions on Semiconductor Manufacturing, 2012, 25, 272-283. | 1.4 | 16 |
| 56 | Optimal process mean and quality improvement in a supply chain model with two-part trade credit based on Taguchi loss function. International Journal of Production Research, 2018, 56, 5234-5248. | 4.9 | 16 |
| 57 | An improved sampling plan by variables inspection with consideration of process yield and quality loss. Journal of Statistical Computation and Simulation, 2019, 89, 2395-2409. | 0.7 | 16 |
| 58 | Capability measure for asymmetric tolerance non-normal processes applied to speaker driver manufacturing. International Journal of Advanced Manufacturing Technology, 2005, 25, 506-515. | 1.5 | 15 |
| 59 | Generalized Confidence Intervals for Comparing the Capability of Two Processes. Communications in Statistics - Theory and Methods, 2010, 39, 2351-2364. | 0.6 | 15 |
| 60 | DEA window analysis for assessing efficiency of blistering process in a pharmaceutical industry. Neural Computing and Applications, 2019, 31, 3703-3717. | 3.2 | 15 |
| 61 | Design and construction of a variables quick switching sampling system based on Taguchi capability index. Computers and Industrial Engineering, 2021, 160, 107582. | 3.4 | 15 |
| 62 | Generalized confidence intervals for the process capability index C pm. Metrika, 2008, 68, 65-82. | 0.5 | 14 |
| 63 | Fuzzy nonlinear programming approach for evaluating and ranking process yields with imprecise data. Fuzzy Sets and Systems, 2014, 246, 142-155. | 1.6 | 14 |
| 64 | Quality-yield measure for production processes with very low fraction defective. International Journal of Production Research, 2004, 42, 4909-4925. | 4.9 | 13 |
| 65 | Distributional and Inferential Properties of the Process Loss Indices. Journal of Applied Statistics, 2004, 31, 1115-1135. | 0.6 | 13 |
| 66 | Accuracy Analysis of the Percentile Method for Estimating Non Normal Manufacturing Quality. Communications in Statistics Part B: Simulation and Computation, 2007, 36, 657-697. | 0.6 | 13 |
| 67 | Applying Bayesian approach to assess process capability for asymmetric tolerances based on <mml:math <br="" altimg="si1.gif" xmlns:mml="http://www.w3.org/1998/Math/MathML">overflow="scroll"><mml:mrow><mml:msubsup><mml:mrow><mml:mi>C</mml:mi></mml:mrow><mml:mrow><mml:mo>>â€3</mml:mo>></mml:mrow></mml:msubsup></mml:mrow><td>⟨m₂n₂mi isubsup≻<</td><td>13 :/mml:mrow></td></mml:math> | ⟨m ₂n₂ mi isubsup≻< | 13 :/mml:mrow> |
| 68 | An improved approach for process performance evaluation with the consideration of process yield and quality loss. International Journal of Production Research, 2013, 51, 6397-6409. | 4.9 | 13 |
| 69 | A Situationally Sampleâ€6izeâ€Adjusted Sampling Scheme Based on Process Yield Verification. Quality and Reliability Engineering International, 2017, 33, 57-69. | 1.4 | 13 |
| 70 | Determining optimal process mean and quality improvement in a profit-maximization supply chain model. Quality Technology and Quantitative Management, 2019, 16, 154-169. | 1.1 | 13 |
| 71 | An integrated failure-censored sampling scheme for lifetime-performance verification and validation under a Weibull distribution. Quality Engineering, 2022, 34, 82-95. | 0.7 | 13 |
| 72 | Generalized confidence intervals for assessing process capability of multiple production lines. Quality and Reliability Engineering International, 2009, 25, 701-716. | 1.4 | 12 |

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| 73 | A Bayesian procedure for assessing process performance based on the third-generation capability index. Journal of Applied Statistics, 2009, 36, 1205-1223. | 0.6 | 12 |
| 74 | An improved approach for constructing lower confidence bound on process yield. European Journal of Industrial Engineering, 2012, 6, 369. | 0.5 | 12 |
| 75 | Fuzzy inference to supplier evaluation and selection based on quality index: a flexible approach. Neural Computing and Applications, 2013, 23, 117-127. | 3.2 | 11 |
| 76 | An adjustable inspection scheme for lot sentencing based on one-sided capability indices. Applied Mathematical Modelling, 2021, 96, 766-778. | 2.2 | 11 |
| 77 | Tool replacement for production with a low fraction of defectives. International Journal of Production Research, 2006, 44, 2313-2326. | 4.9 | 10 |
| 78 | Process performance evaluation based on Taguchi capability index with the consideration of measurement errors. International Journal of Systems Science, 2013, 44, 1386-1399. | 3.7 | 10 |
| 79 | Developing a variables two-plan sampling system for product acceptance determination. Communications in Statistics - Theory and Methods, 2017, 46, 706-720. | 0.6 | 10 |
| 80 | Bayesian approach for measuring EEPROM process capability based on the one-sided indices CPU and CPL. International Journal of Advanced Manufacturing Technology, 2006, 31, 135-144. | 1.5 | 9 |
| 81 | An integrated inventory model with quality improvement and two-part credit policy. Top, 2014, 22, 1042-1061. | 1.1 | 9 |
| 82 | Performance evaluation of processes with asymmetric tolerances in the presence of gauge measurement errors. Communications in Statistics - Theory and Methods, 2016, 45, 3011-3026. | 0.6 | 9 |
| 83 | Improved inspection scheme with a loss-based capability index. International Journal of Advanced Manufacturing Technology, 2019, 104, 1321-1331. | 1.5 | 9 |
| 84 | A modified sampling plan by variables with an adjustable mechanism for lot sentencing. Journal of the Operational Research Society, 2021, 72, 678-687. | 2.1 | 9 |
| 85 | Measuring Process Performance Based on Expected Loss with Asymmetric Tolerances. Journal of Applied Statistics, 2006, 33, 1105-1120. | 0.6 | 8 |
| 86 | A comparison of methods forsing loss-based capability index. Journal of Statistical Computation and Simulation, 2009, 79, 1129-1141. | 0.7 | 8 |
| 87 | An Integrated Inventory Model with Order-Size-Dependent Trade Credit and Quality Improvement. Procedia Computer Science, 2013, 17, 365-372. | 1.2 | 8 |
| 88 | Variables skip-lot sampling plans on the basis of process capability index for products with a low fraction of defectives. Computational Statistics, 2021, 36, 1391-1413. | 0.8 | 8 |
| 89 | Developing a skip-lot sampling scheme by variables inspection using repetitive sampling as a reference plan. International Journal of Production Research, 2022, 60, 3018-3030. | 4.9 | 8 |
| 90 | Designing acceptance sampling plans based on the lifetime performance index under gamma distribution. International Journal of Advanced Manufacturing Technology, 2021, 115, 3409-3422. | 1.5 | 8 |

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| 91 | Process Performance Evaluation with Imprecise Information. Journal of Testing and Evaluation, 2010, 38, 102480. | 0.4 | 8 |
| 92 | Designing a yield-based skip-lot sampling plan for lot acceptance determination. Journal of the Operational Research Society, 0, , 1-22. | 2.1 | 8 |
| 93 | Procedures for testing manufacturing precision Cpbased on (\$ar{x}\$,R) or (\$ar{x}\$,S) control chart samples. International Journal of Advanced Manufacturing Technology, 2005, 25, 598-607. | 1.5 | 7 |
| 94 | Quality yield measure for processes with asymmetric tolerances. IIE Transactions, 2006, 38, 619-633. | 2.1 | 7 |
| 95 | A Bayesian approach for measuring process performance with asymmetric tolerances. European Journal of Industrial Engineering, 2012, 6, 347. | 0.5 | 7 |
| 96 | A flexible sampling scheme for variables inspection with loss consideration. Journal of Statistical Computation and Simulation, 2015, 85, 3766-3777. | 0.7 | 7 |
| 97 | Reliable confidence intervals for assessing normal process incapability. Communications in Statistics Part B: Simulation and Computation, 2017, 46, 446-457. | 0.6 | 7 |
| 98 | Acceptance sampling schemes for two-parameter Lindley lifetime products under a truncated life test. Quality Technology and Quantitative Management, 0, , 1-14. | 1.1 | 7 |
| 99 | Multiple-process performance analysis chart based on process loss indices. International Journal of Systems Science, 2006, 37, 429-435. | 3.7 | 6 |
| 100 | On ranking multiple touch-screen panel suppliers through the CTQ: applied fuzzy techniques for inspection with unavoidable measurement errors. Neural Computing and Applications, 2014, 25, 481-490. | 3.2 | 6 |
| 101 | Testing and Ranking Multiple Wafer-Manufacturing Processes With Fuzzy-Quality Data. Journal of Testing and Evaluation, 2016, 44, 1970-1977. | 0.4 | 6 |
| 102 | Capability Testing Based on Subsamples: A Case on Photolithography Process Control in Wafer Fabrication. Journal of Testing and Evaluation, 2010, 38, 222-231. | 0.4 | 6 |
| 103 | An integrated operating mechanism for lot sentencing based on process yield. Quality Technology and Quantitative Management, 2022, 19, 139-152. | 1.1 | 6 |
| 104 | AN EFFECTIVE MODERN APPROACH FOR MEASURING HIGH-TECH PRODUCT MANUFACTURING PROCESS QUALITY. Journal of the Chinese Institute of Industrial Engineers, 2005, 22, 119-133. | 0.5 | 5 |
| 105 | Hybrid Genetic Algorithm for Solving Assembly Line Balancing Problem in Footwear Industry. Advanced Materials Research, 0, 939, 623-629. | 0.3 | 5 |
| 106 | Standardized lifetime-capability and warranty-return-rate-based suppliers qualification and selection with accelerated Weibull-life type II testing data. Communications in Statistics - Theory and Methods, 2022, 51, 8186-8204. | 0.6 | 5 |
| 107 | Design and construction of a quick-switching sampling system with a third-generation capability index. Communications in Statistics - Theory and Methods, 2023, 52, 3633-3651. | 0.6 | 5 |
| 108 | Two Tests for Supplier Selection Based on Process Yield. Journal of Testing and Evaluation, 2011, 39, 126-133. | 0.4 | 5 |

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| 109 | Stage-independent multiple sampling plan by variables inspection for lot determination based on the process capability index <i>C_{pk}</i> . International Journal of Production Research, 2023, 61, 3171-3183. | 4.9 | 5 |
| 110 | Bootstrap approach for estimating process quality yield with application to light emitting diodes. International Journal of Advanced Manufacturing Technology, 2005, 25, 560-570. | 1.5 | 4 |
| 111 | Fuzzy estimation for process loss assessment. Journal of the Chinese Institute of Engineers, Transactions of the Chinese Institute of Engineers,Series A/Chung-kuo Kung Ch'eng Hsuch K'an, 2014, 37, 1-6. | 0.6 | 4 |
| 112 | Prediction of paravalvular leak post transcatheter aortic valve replacement using a convolutional neural network. , 2018, , . | | 4 |
| 113 | Evaluating process performance based on the incapability index for measurements with uncertainty. Expert Systems With Applications, 2010, 37, 5999-6006. | 4.4 | 3 |
| 114 | Duopoly competition with non-deceptive counterfeiters. International Review of Law and Economics, 2016, 47, 33-40. | 0.5 | 3 |
| 115 | Process Capability Assessment for Asymmetric Tolerances with Consideration of Gauge Measurement Errors. Communications in Statistics Part B: Simulation and Computation, 2016, 45, 519-547. | 0.6 | 3 |
| 116 | Yieldâ€based variables repetitive group plan with a criticalâ€valueâ€adjusted mechanism. Quality and Reliability Engineering International, 2022, 38, 3017-3032. | 1.4 | 3 |
| 117 | A Bayesian Procedure for Assessing Process Performance Based on Expected Relative Loss with Asymmetric Tolerances. Journal of Applied Statistics, 2007, 34, 1109-1123. | 0.6 | 2 |
| 118 | A fuzzy-neural approach for optimizing the performance of job dispatching in a wafer fabrication factory. International Journal of Advanced Manufacturing Technology, 2013, 67, 189-202. | 1.5 | 2 |
| 119 | Turning counterfeiting into advantage: the case of a durable good monopolist. Applied Economics Letters, 2014, 21, 1122-1127. | 1.0 | 2 |
| 120 | Supplier selection based on normal process yield: the Bayesian inference. Neural Computing and Applications, 2020, 32, 4121-4133. | 3.2 | 2 |
| 121 | Assessing True TFT-LCD Process Quality in the Presence of Unavoidable Measurement Errors. Journal of Testing and Evaluation, 2015, 43, 20140103. | 0.4 | 2 |
| 122 | A repetitive group sampling plan based on the lifetime performance index under gamma distribution. Quality and Reliability Engineering International, 0, , . | 1.4 | 2 |
| 123 | On the Sampling Distributions of the Estimated Process Loss Indices with Asymmetric Tolerances. Communications in Statistics Part B: Simulation and Computation, 2007, 36, 1153-1170. | 0.6 | 1 |
| 124 | A Hypothesis Testing Procedure on Assessing Process Performance for Asymmetric Tolerances. Communications in Statistics - Theory and Methods, 2008, 37, 1959-1976. | 0.6 | 1 |
| 125 | Estimating and testing process accuracy with extension to asymmetric tolerances. Quality and Quantity, 2010, 44, 985-995. | 2.0 | 1 |
| 126 | An alternative approach to control tool wear problem with an application to grinding wheels management in manufacturing silicon wafers. Journal of Information and Optimization Sciences, 2010, 31, 231-244. | 0.2 | 1 |

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|-----|--|-----|-----------|
| 127 | A new lot sentencing method by variables inspection. , 2014, , . | | 1 |
| 128 | Assessing S-Type Process Quality of Data Involving Batch-to-Batch Variation. Journal of Testing and Evaluation, 2017, 45, 1425-1435. | 0.4 | 1 |
| 129 | Developing a variables modified chain sampling plan with Taguchi capability index. Quality and Reliability Engineering International, 0, , . | 1.4 | 1 |
| 130 | Comparisons of frequentist and Bayesian inferences for interval estimation on process yield. Journal of the Operational Research Society, 2022, 73, 2694-2705. | 2.1 | 1 |
| 131 | Quality Technology and Quantitative Management Reliability Monitoring and Performance Measuring for the Exponential Failure Process. , 2007, , . | | 0 |
| 132 | Measuring process yield by fuzzy lower confidence bounds. , 2010, , . | | 0 |
| 133 | A novel approach for measuring the maximum process-loss information in multiple production line conditions. International Journal of Production Research, 2012, 50, 3809-3820. | 4.9 | 0 |
| 134 | A Tribute to George Box $\hat{a} \in$ "Statistical Methodologies and Applications Foreword. Quality Technology and Quantitative Management, 2015, 12, 1-3. | 1.1 | 0 |
| 135 | Developing a Variables Modified Chain Sampling Plan with Taguchi Capability Index. , 2020, , . | | 0 |
| 136 | A new switching model for sampling plan based on process yield. , 2020, , . | | 0 |